

Application/Control No.	Applicant(s)/Patent un Reexamination	der
09/894,827	FUKUSHIGE ET AL.	
Examiner	Art Unit	
John S. Chu	1752	

	SEARCHED				
Class	Subclass	Date	Examiner		
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430	281.1				
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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